

# Systematic uncertainties

## • Normalization with spectrometer A

For a single measurement (run) we can say, that  $\sigma$  for this measurement is:

$$(495 \text{ MeV}) : \sigma_i = \frac{0.00053}{0.1015} = 0.522\%$$

I have 10 runs. How much does this affect the

average:

$$\bar{\sigma} = \frac{\sqrt{\sum \sigma_i^2}}{N} = \frac{\sqrt{N \sigma_i^2}}{N} = \frac{\sigma_i}{\sqrt{N}} = \underline{\underline{0.165\%}}$$

$$(330 \text{ MeV}) : \sigma_i = \frac{0.00089}{0.32069} = 0.2775\% \quad \left| \quad \bar{\sigma} = \underline{\underline{0.09\%}} \right.$$

## • Cerenkov and Scintillation detectors:

$$\bar{E}_{\text{cerk}} : \epsilon_{\text{eff}} = 99.7388 \pm 0.02127\% \quad ?$$

$$T_{\text{eff}} : \delta_{\text{eff}} \leq 0.2\%$$

$$V_{\text{dd}} : \delta_{\text{eff}} \leq 0.02\%$$

$$\delta_{\text{TOT}} = 0.2\%$$

This error change  
the amplitude, normalization,  
but does not change  
the slope, i.e., width.

## MAID

New threshold the MAID has accuracy of approx  $\sim 5-10\%$ ; Having approx.  $10^7$  events in the lowest bins, the uncertainty  $\sim \underline{\underline{0.5-1\%}}$ .

## Background Simulation:

check this!

We know the simulation to  $\leq 5\%$ . (Probably  $\leq 2\%$ .)

The largest contribution to data at lowest setting:

$$\boxed{495 \text{ MeV}} : \delta = \frac{470 \text{ cuts}}{10000 \text{ cuts}} \cdot 5\% = 0.24\%$$

10k

470

$$\boxed{330 \text{ MeV}: 330-02} : \delta = \frac{400 \text{ cuts}}{14400 \text{ cuts}} \cdot 5\% = 0.14\%$$

## Contribution of the $\mu$ -diagrams:

$$\delta = 3 \cdot 10^{-4} = 0.03\%$$

## Higher order corrections: (dominated by the lepton side)

The largest correction in the first order is  $2p$  emission. (50%). In the third order

$$\delta_{3rd} = \frac{50\%}{137} = \underline{\underline{0.36\%}}$$